

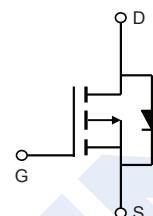
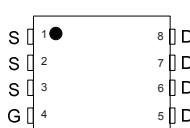
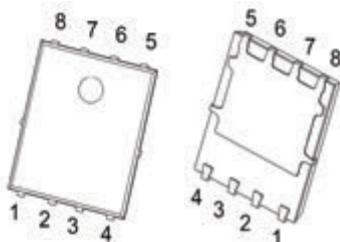
P-Channel MOSFET

2KJ6043DFN

■ Features

- $V_{DS} = -30V$
- $I_D = -36A$
- $R_{DS(ON)} < 7.8m\Omega @ V_{GS} = -10V$
- $R_{DS(ON)} < 12.3m\Omega @ V_{GS} = -4.5V$

PDFN5x6-8

■ Absolute Maximum Ratings ($T_A = 25^\circ C$ unless otherwise noted)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-30	V
Gate-Source Voltage	V_{GS}	± 25	
Continuous Drain Current (Note 1)	I_D	-36	A
Pulsed Drain Current (Note 2)	I_{DM}	-144	
Avalanche Current (Note 2)	I_{AS}	39	A
Avalanche Energy $L = 0.1mH$ (Note 2)	E_{AS}	76	mJ
Thermal Resistance, Junction- to-Ambient (Note 3, 5)	R_{JA}	55	$^\circ C/W$
Thermal Resistance, Junction- to-Case	R_{JC}	2.6	
Power Dissipation (Note 4)	P_D	48	W
		19	
Power Dissipation (Note 5)	P_{DSM}	5.0	
		3.2	
Junction Temperature	T_J	150	$^\circ C$
Storage Temperature Range	T_{STG}	-55 to 150	

Notes:

1. The maximum current rating is package limited.
2. Single pulse width limited by junction temperature $T_J(MAX)=150^\circ C$.
3. The R_{JA} is the sum of the thermal impedance from junction to case R_{JC} and case to ambient.
4. The power dissipation P_D is based on $T_J(MAX)=150^\circ C$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
5. The value of R_{JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ C$. The Power dissipation P_{DSM} is based on $R_{JA} \leq 10s$ and the maximum allowed junction temperature of $150^\circ C$. The value in any given application depends on the user's specific board design.

2KJ6043DFN**■ Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise noted)**

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Off characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$I_D = -250\mu\text{A}, V_{GS} = 0\text{V}$	-30			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS} = -30\text{V}, V_{GS} = 0\text{V}$			-1	μA
		$V_{DS} = -30\text{V}, V_{GS} = 0\text{V}, T_J = 55^\circ\text{C}$			-5	
Gate-Body Leakage Current	I_{GSS}	$V_{DS} = 0\text{V}, V_{GS} = \pm 25\text{V}$			± 100	nA
On characteristics						
Gate Threshold Voltage	$V_{GS(\text{th})}$	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$	-1.0		-2.0	V
Static Drain-Source On-Resistance	$R_{DS(\text{ON})}$	$V_{GS} = -10\text{V}, I_D = -20\text{A}$			7.8	$\text{m}\Omega$
		$V_{GS} = -10\text{V}, I_D = -20\text{A}, T_J = 125^\circ\text{C}$			10.7	
		$V_{GS} = -4.5\text{V}, I_D = -20\text{A}$			12.3	
Forward Transconductance	g_{FS}	$V_{DS} = -5\text{V}, I_D = -20\text{A}$		50		S
Dynamic characteristics						
Input Capacitance	C_{iss}	$V_{GS}=0\text{V}, V_{DS} = -15\text{V}, f = 1\text{MHz}$		2830		pF
Output Capacitance	C_{oss}			430		
Reverse Transfer Capacitance	C_{rss}			365		
Gate Resistance	R_g	$f = 1\text{MHz}$		14	28	Ω
Switching characteristics						
Total Gate Charge	$Q_g(10\text{V})$	$V_{DS} = -15\text{V}, I_D = -20\text{A}, V_{GS} = -10\text{V}$		50	70	nC
	$Q_g(4.5\text{V})$			25	35	
Gate Source Charge	Q_{gs}			9		
Gate Drain Charge	Q_{gd}			12		
Turn-On Delay Time	$t_{d(on)}$	$V_{DD}=-15\text{V}, R_L=0.75\Omega, V_{GS}=-10\text{V}, R_{GEN}=3\Omega$		12.5		ns
Turn-On Rise Time	t_r			18		
Turn-Off Delay Time	$t_{d(off)}$			125		
Turn-Off Fall Time	t_f			66		
Drain-Source Diode Characteristics						
Reverse Recovery Time	t_{rr}	$I_F=-20\text{A}, dI/dt=-500\text{A}/\mu\text{s}$		32		nS
Reverse Recovery Charge	Q_{rr}			62		nC
Diode Forward Current	I_S				-36	A
Diode Forward Voltage	V_{SD}	$I_S = -1\text{ A}, V_{GS} = 0\text{V}$		-0.7	-1.0	V

Notes:

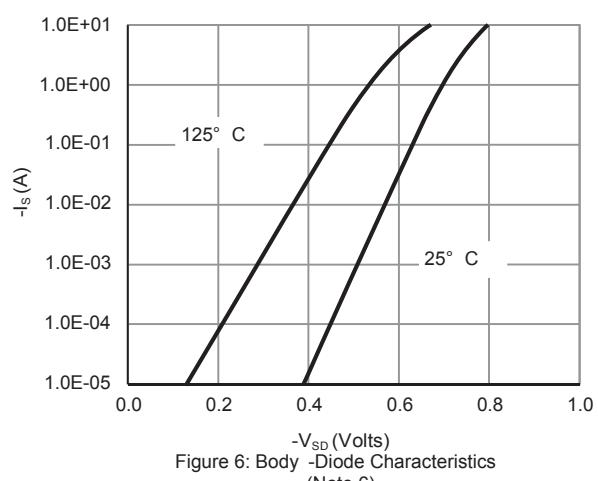
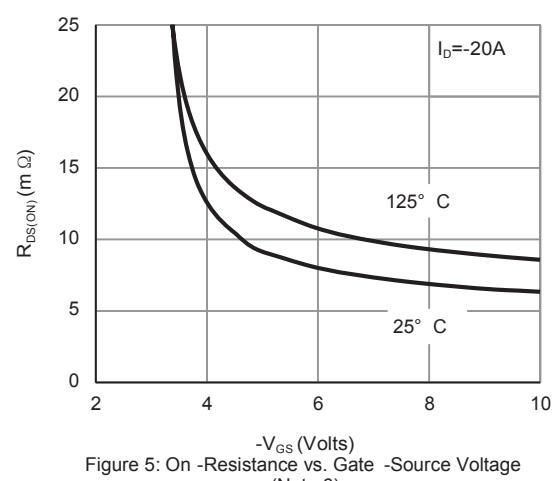
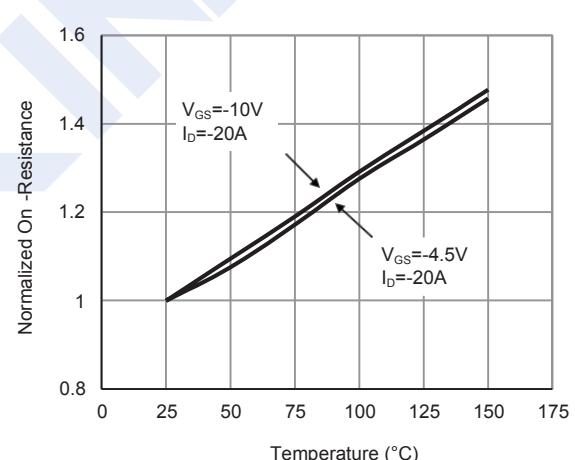
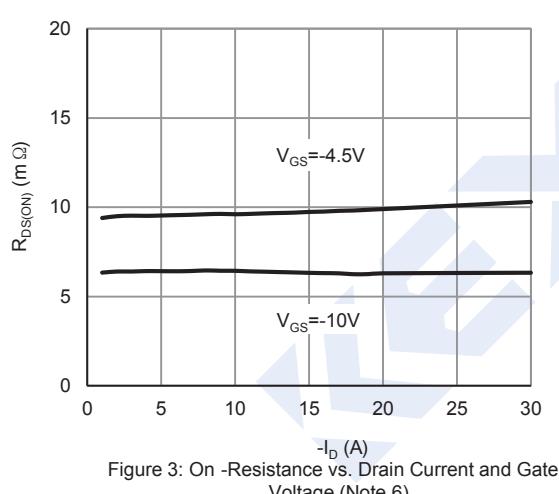
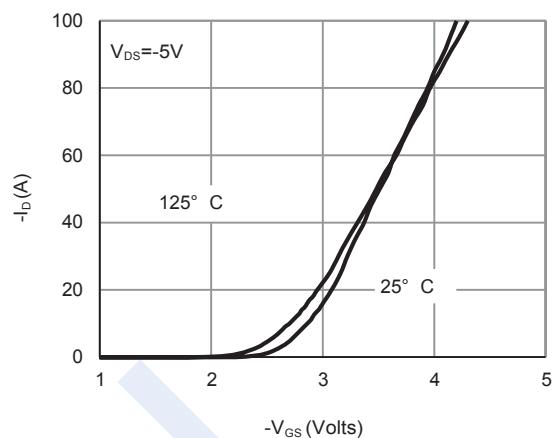
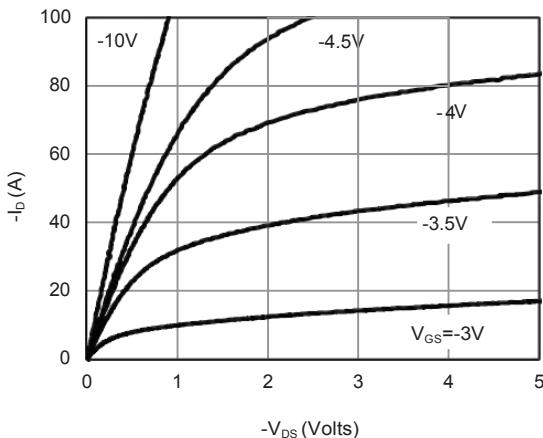
6. The static characteristics in Figures 1 to 6 are obtained using $<300\mu\text{s}$ pulses, duty cycle 0.5% max.
7. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_J(\text{MAX})=150^\circ\text{C}$. The SOA curve provides a single pulse rating.
8. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25^\circ\text{C}$.

■ Marking

Marking	J6043 KC****
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2KJ6043DFN

■ Typical Electrical and Thermal Characteristics



2KJ6043DFN

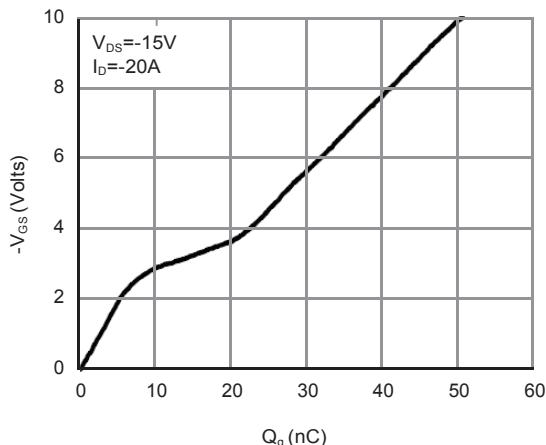


Figure 7: Gate -Charge Characteristics

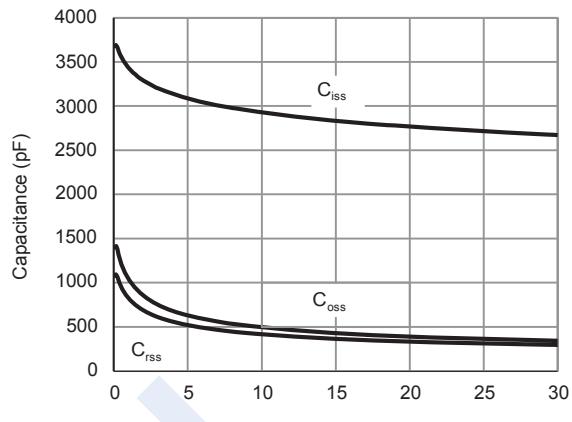


Figure 8: Capacitance Characteristics

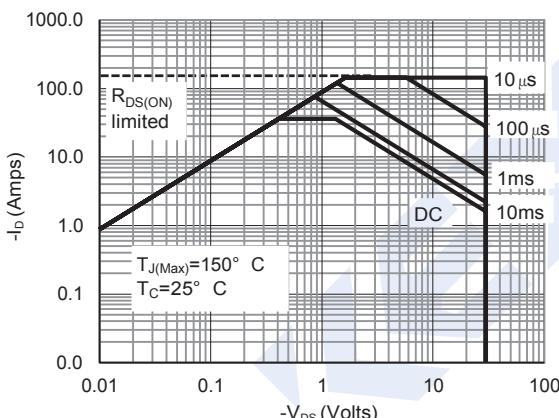


Figure 9: Maximum Forward Biased Safe Operating Area (Note 7)

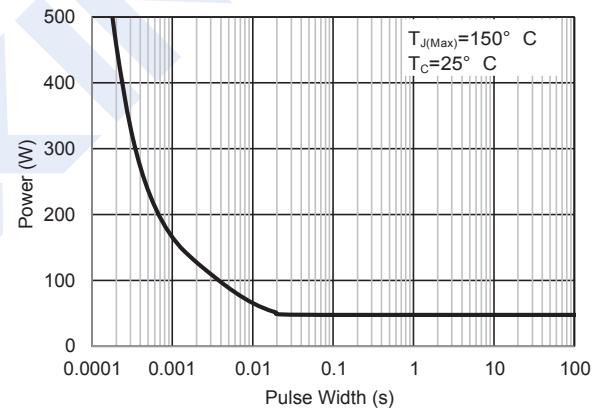


Figure 10: Single Pulse Power Rating Junction -to- Case (Note 7)

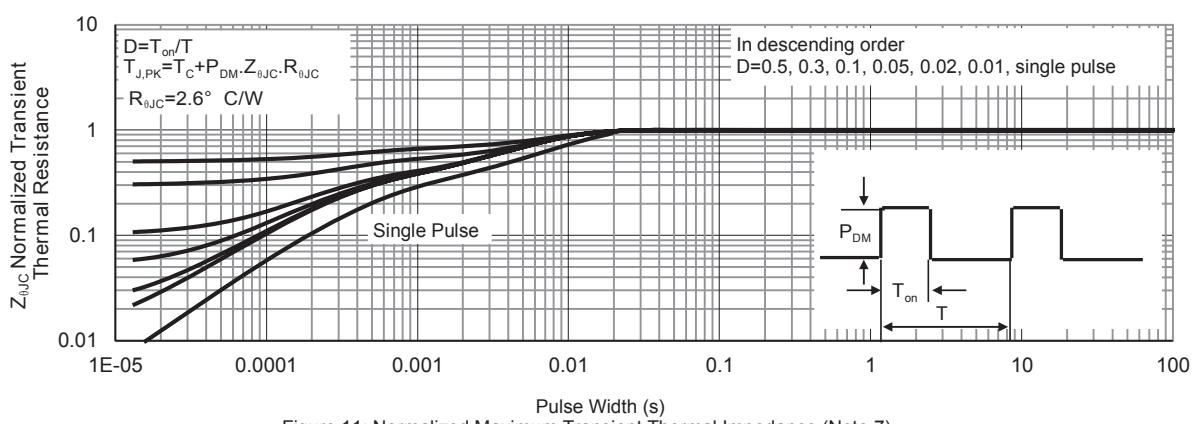


Figure 11: Normalized Maximum Transient Thermal Impedance (Note 7)

2KJ6043DFN

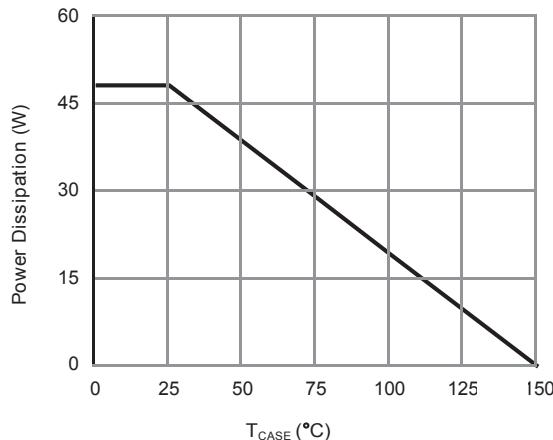


Figure 12: Power De-rating (Note 7)

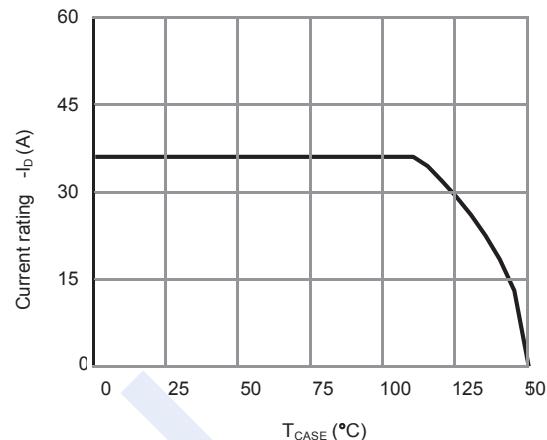


Figure 13: Current De-rating (Note 7)

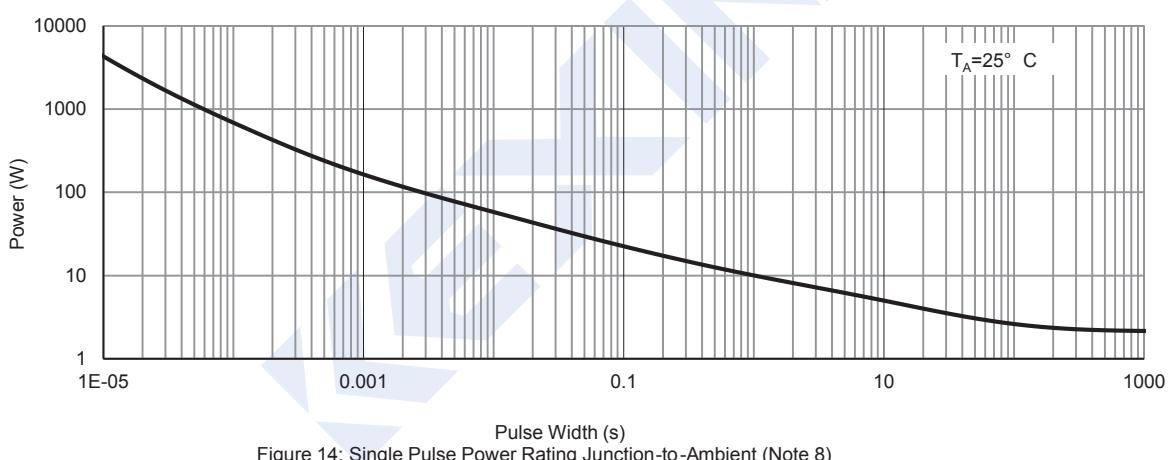


Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note 8)

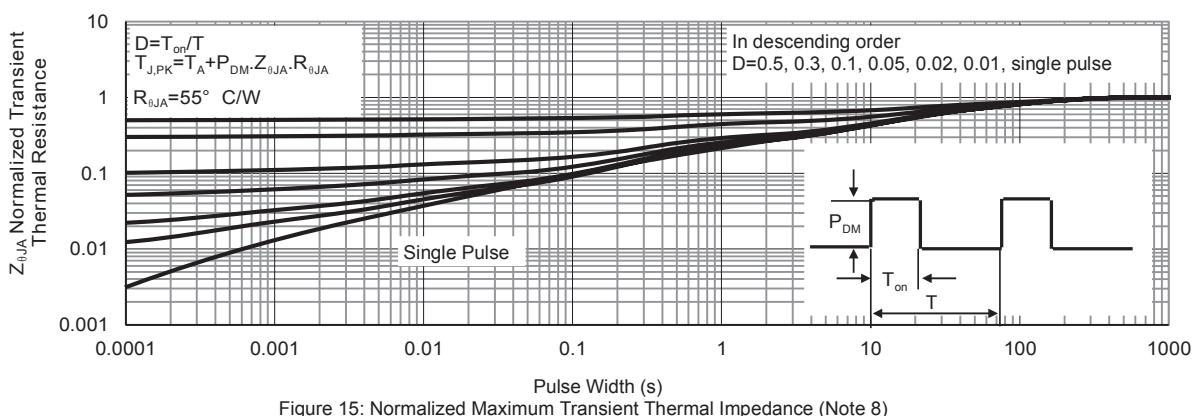
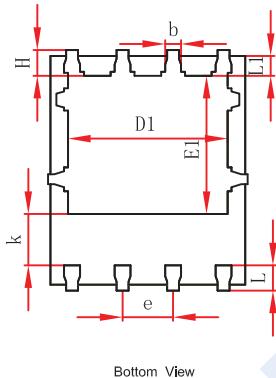
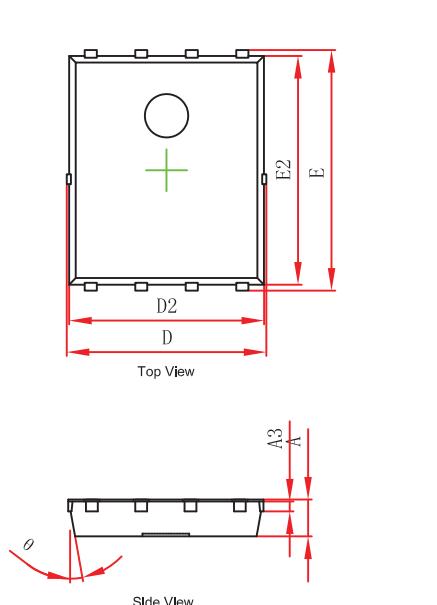
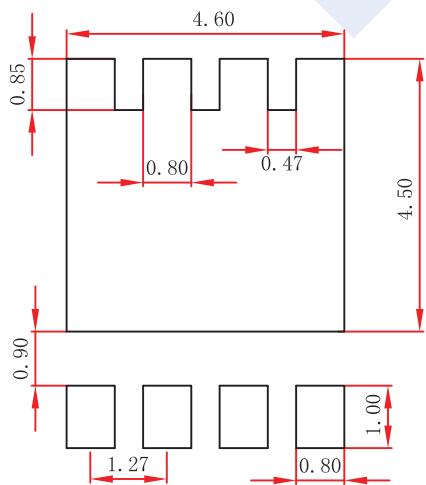


Figure 15: Normalized Maximum Transient Thermal Impedance (Note 8)

2KJ6043DFN**■ PDFN5x6-8 Package Outline Dimensions**

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.900	1.000	0.035	0.039
A3	0.254REF.		0.010REF.	
D	4.944	5.096	0.195	0.201
E	5.974	6.126	0.235	0.241
D1	3.910	4.110	0.154	0.162
E1	3.375	3.575	0.133	0.141
D2	4.824	4.976	0.190	0.196
E2	5.674	5.826	0.223	0.229
k	1.190	1.390	0.047	0.055
b	0.350	0.450	0.014	0.018
e	1.270TYP.		0.050TYP.	
L	0.559	0.711	0.022	0.028
L1	0.424	0.576	0.017	0.023
H	0.574	0.726	0.023	0.029
θ	10°	12°	10°	12°

■ PDFN5x6-8 Suggested Pad Layout**Note:**

1. Controlling dimension:in millimeters.
- 2.General tolerance: $\pm 0.05\text{mm}$.
- 3.The pad layout is for reference purposes only.